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Electro-Optical and Infrared Systems: Technology and Applications XI

**David A. Huckridge
Reinhard Ebert**
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and an abbreviated version on subsequent pages. Numbers in the index correspond to the last two digits of the six-digit CID Number.

Contents

vii	<i>Authors</i>
ix	<i>Conference Committee</i>

SESSION 1 ELECTRO-OPTICAL SYSTEMS AND APPLICATIONS

- 9249 02 **Method for increased detection range in IR warning systems** [9249-1]
- 9249 04 **Modeling transient thermal behavior of shutter-less microbolometer-based infrared cameras** [9249-3]
- 9249 06 **Optical fibre techniques for use within tamper indicating enclosures designed for arms control verification purposes (Best Student Paper)** [9249-5]

SESSION 2 SYSTEMS COMPONENTS AND TESTING

- 9249 07 **Passive athermalization of doublets in 8-13 micron waveband** [9249-6]
- 9249 08 **Protection performance evaluation regarding imaging sensors hardened against laser dazzling** [9249-7]
- 9249 09 **Evaluation of super-resolution imager with binary fractal test target** [9249-8]

SESSION 3 SIMULATION AND MODELLING

- 9249 0B **Software thermal imager simulator** [9249-10]
- 9249 0C **A target detection model predicting field observer performance in maritime scenes** [9249-11]
- 9249 0D **Exact expressions for thermal contrast detected with thermal and quantum detectors** [9249-12]
- 9249 0E **Performance optimization for space-based sensors: simulation and modelling at Fraunhofer IOSB** [9249-13]
- 9249 0F **Contrast analysis of space-based Earth observation infrared system** [9249-14]

SESSION 4 ACTIVE IMAGING AND TARGET DESIGNATION

- 9249 0H **Novel eye-safe line scanning 3D laser-radar** [9249-16]

SESSION 5 IMAGE PROCESSING

- 9249 OJ **A new incremental principal component analysis with a forgetting factor for background estimation** [9249-19]
- 9249 OK **An embedded face-classification system for infrared images on an FPGA** [9249-20]
- 9249 OL **A texture-based architecture for face detection in IR images on an FPGA** [9249-21]

SESSION 6 ELECTRO-OPTICAL TECHNOLOGY IN THE NETHERLANDS

- 9249 OM **Research topics on EO systems for maritime platforms (Keynote Paper)** [9249-22]
- 9249 ON **Ship recognition for improved persistent tracking with descriptor localization and compact representations** [9249-23]
- 9249 OO **Turbulence mitigation methods and their evaluation** [9249-24]
- 9249 OP **NVG-the-Day: towards realistic night-vision training** [9249-25]
- 9249 OQ **Efficient contrast enhancement through log-power histogram modification** [9249-26]
- 9249 OR **A TOD dataset to validate human observer models for target acquisition modeling and objective sensor performance testing** [9249-27]
- 9249 OS **Detection and tracking of humans from an airborne platform** [9249-28]
- 9249 OT **Focus-of-attention for human activity recognition from UAVs** [9249-29]

SESSION 7 SPECTRAL SYSTEMS

- 9249 OU **Time-resolved thermal infrared multispectral imaging of gases and minerals** [9249-30]
- 9249 OW **SYSIPHE system: a state of the art airborne hyperspectral imaging system: initial results from the first airborne campaign** [9249-31]
- 9249 OY **A next generation VNIR-SWIR hyperspectral camera system: HySpex ODIN-1024** [9249-32]

SESSION 8 DETECTORS

- 9249 OV **CMOS-TDI detector technology for reconnaissance application** [9249-34]
- 9249 OX **Optimization of InGaAs/InAlAs APDs for SWIR detection with demand for high gain and low breakdown voltage** [9249-35]
- 9249 OZ **InGaAs focal plane array developments and perspectives** [9249-36]
- 9249 11 **New SOFRADIR 10 μ m pixel pitch infrared products** [9249-38]

POSTER SESSION

- 9249 14 **Explosion-proof fiber optic fire detector: design and mathematical description [9249-42]**
- 9249 15 **Optical encryption in spatially-incoherent light using two LC SLMs for both information input and encryption element imaging [9249-43]**
- 9249 16 **Fabrication of chalcogenide glass lens module for thermal security camera [9249-44]**
- 9249 18 **A regional density distribution based wide dynamic range algorithm for infrared camera systems [9249-46]**
- 9249 1A **Infrared target detection in large field of view using visual attention [9249-48]**
- 9249 1B **Improvement of quality of optical reconstruction of digital Fourier holograms displayed on phase-only SLM by its digital preprocessing [9249-49]**

Authors

Numbers in the index correspond to the last two digits of the six-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first four digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Aidam, R., 0X
Arad, Eyal, 02
Aufranc, S., 11
Augey, T., 11
Baarstad, Ivar, 0W, 0Y
Benoist, Koen W., 0N
Bergeron, Alain, 0B
Berthiaume, François, 0B
Bijl, Piet, 0M, 0R
Billon-Lanfrey, D., 11
Bisotto, S., 11
Blaaberg, Søren, 0W, 0Y
Bolduc, Martin, 0B
Bondareva, Alyona P., 15
Bouma, Henri, 0N
Bronner, W., 0X
Budzier, H., 04
Burghouts, Gertjan, 0S, 0T
Cha, Du Hwan, 16
Chamberland, Martin, 0U
Chen, Zengping, 1A
Cheremkhin, Pavel A., 15, 1B
Costard, E., 0Z
Coudrain, Christophe, 0W
Coussement, J., 0Z
Culpepper, Joanne B., 0C
Debaque, Benoît, 0B
Decaens, G., 11
den Hollander, Richard J. M., 0N
Dijk, Judith, 0M, 0O, 0S, 0T
Doucet, Michel, 0B
Dufour, Denis, 0B
Dyer, Thomas C., 06
Eberle, Bernd, 08, 0H
Eckardt, Andreas, 0V
Evtikhiev, Nikolay N., 15, 1B
Fabre, Sophie, 0W
Farley, Vincent, 0U
Figuroa, Miguel, 0K, 0L
Forster, Daniel, 08
Fridman, Andrei, 0W, 0Y
Gagnon, Marc-André, 0U
Gerlach, G., 04
Gravrand, O., 11
Guyot, Éric, 0U
Hama, Hiromitsu, 0J
Hamard, S., 0Z
Hammer, Marcus, 0H
He, Xiaoyu, 0F
Heussen, H., 0X
Hogervorst, Maarten A., 0P, 0R
Huet, O., 0Z
Hwang, Yeon, 16
Jahjah, Karl-Alexandre, 0U
Johnson, R. Barry, 0D
Joung, Shichang, 18
Jung, Melanie, 0V
Kazakov, V. I., 14
Kem, Tobias, 0H
Kim, Dong-Sik, 16
Kim, Hye-Jeong, 16
Kim, Jeong-Ho, 16
Kim, Yongsung, 18
Kleinow, P., 0X
Koerber, Michael, 08
Koirala, Pesal, 0Y
Kooi, Frank L., 0P, 0R
Krasnov, Vitaly V., 15, 1B
Krause, V., 04
Landeau, Stéphane, 09
Le Noc, Loic, 0B
Lefoul, X., 11
Liu, Songlin, 1A
Løke, Trond, 0W, 0Y
Maillart, P., 0Z
Marchese, Linda, 0B
Marcotte, Frédéric, 0U
Mazaleyrat, E., 11
Mocoeur, Isabelle, 0W
Moskaletz, O. D., 14
Nowak, Heinrich, 0H
Oubensaid, E. H., 0Z
Pancrati, Ovidiu, 0B
Park, Gyuhee, 18
Pere-Laperne, N., 11
Porshneva, Liudmila A., 1B
Poutier, Laurent, 0W
Pozzi, M., 0Z
Reibel, Y., 11
Reulke, Ralf, 0V
Ricard, N., 11
Rift, Gunnar, 08
Rodin, Vladislav G., 15, 1B
Roit, Paula, 02
Roussel-Rouviere, Laurent, 0W
Rouvié, A., 0Z
Rubaldo, L., 11
Rutz, F., 0X

Saint-Laurent, Louis, 0B
Schuster, Norbert, 07
Schutte, Klamer, 0O
Schwanke, Ullrich, 0H
Schweitzer, Caroline, 0E
Schwering, Piet B. W., 0N
Sengebusch, Karsten, 0V
Shin, Sanghoon, 18
Skauli, Torbjorn, 0W
Soto, Javier E., 0K
Starikov, Sergey N., 15, 1B
Stein, Karin, 0E
Stewart, Seán M., 0D
Sun, Gang, 1A
Tempelhahn, A., 04
Thompson, Alexander W. J., 06
Toet, Alexander, 0Q
Torii, Takashi, 0J
Tremblay, Pierre, 0U
Truffer, JP., 0Z
Turbide, Simon, 0B
van den Broek, Sebastiaan P., 0M, 0N
van Eekeren, Adam W. M., 0O, 0S, 0T
van Eijk, Alenxander M. J., 0M
Veerman, Henny E. T., 0N
Vergara, Marcelo, 0L
Walther, M., 0X
Wang, Weihua, 1A
Wheaton, Vivienne C., 0C
White, Helen, 06
Wolf, Alejandro, 0L
Wu, Tirui, 0Q
Wynn, Paul, 06
Xu, Xiaojian, 0F
Zin, Thi Thi, 0J

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- 6 Electro-Optical Technology in the Netherlands
Piet Bijl, TNO Defence, Security and Safety (Netherlands)
Judith Dijk, TNO Defence, Security and Safety (Netherlands)
- 7 Spectral Systems
Armin L. Schneider, Institut Franco-Allemand de Recherches de Saint-Louis (France)
- 8 Detectors
Reinhard Ebert, Fraunhofer-Institut für Optronik, Systemtechnik und Bildauswertung (Germany)
David A. Huckridge, Ridgeway Consulting Ltd. (United Kingdom)